捷多邦,专业PCB打样工厂,24小时**MAX23**2, MAX232I DUAL EIA-232 DRIVER/RECEIVER

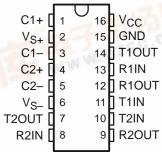
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- Operates With Single 5-V Power Supply
- LinBiCMOS™ Process Technology
- Two Drivers and Two Receivers
- ±30-V Input Levels
- Low Supply Current . . . 8 mA Typical
- Meets or Exceeds TIA/EIA-232-F and ITU Recommendation V.28
- Designed to be Interchangeable With Maxim MAX232
- ESD Protection Exceeds JESD 22
 2000-V Human-Body Model (A114-A)
- Applications

TIA/EIA-232-F Battery-Powered Systems Terminals Modems Computers

 Package Options Include Plastic Small-Outline (D, DW, NS) Packages and Standard Plastic (N) DIPs

D, DW, N, OR NS PACKAGE (TOP VIEW)



description

The MAX232 device is a dual driver/receiver that includes a capacitive voltage generator to supply EIA-232 voltage levels from a single 5-V supply. Each receiver converts EIA-232 inputs to 5-V TTL/CMOS levels. These receivers have a typical threshold of 1.3 V and a typical hysteresis of 0.5 V, and can accept ±30-V inputs. Each driver converts TTL/CMOS input levels into EIA-232 levels. The driver, receiver, and voltage-generator functions are available as cells in the Texas Instruments LinASIC™ library.

The MAX232 is characterized for operation from 0°C to 70°C. The MAX232I is characterized for operation from -40°C to 85°C.

AVAILABLE OPTIONS

FE MAIN	PACKAGED DEVICES			
TA	SMALL OUTLINE (D, NS)	SMALL OUTLINE (DW)	PLASTIC DIP (N)	
0°C to 70°C	MAX232D MAX232NS	MAX232DW	MAX232N	
-40°C to 85°C	MAX232ID	MAX232IDW	MAX232IN	

The D and DW packages are available taped and reeled by adding an R to the part number (i.e., MAX232DR). The NS package is only available taped and reeled.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input supply voltage range, V _{CC} (see Note 1)	0.3 V to 6 V
Positive output supply voltage range, V _{S+}	´	$V_{CC} - 0.3 \text{ V to } 15 \text{ V}$
Negative output supply voltage range, V _S _		0.3 V to -15 V
Input voltage range, V _I : Driver		$-0.3 \text{ V to V}_{CC} + 0.3 \text{ V}$
Receiver		±30 V
Output voltage range, VO: T1OUT, T2OUT		$V_{S-} - 0.3 \text{ V to } V_{S+} + 0.3 \text{ V}$
R1OUT, R2OUT		$-0.3 \text{ V to V}_{CC} + 0.3 \text{ V}$
Short-circuit duration: T1OUT, T2OUT		
Package thermal impedance, θ _{JA} (see Note	2): D package	73°C/W
	DW package	57°C/W
	N package	67°C/W
	NS package	64°C/W
Lead temperature 1,6 mm (1/16 inch) from ca	ase for 10 seconds	260°C
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	V
VIН	V _{IH} High-level input voltage (T1IN,T2IN)		2			V
\vee_{IL}	Low-level input voltage (T1IN, T2IN)				0.8	V
R1IN, R2IN	N Receiver input voltage				±30	V
TA	Operating free-air temperature	MAX232	0		70	°C
		MAX232I	-40		85	



NOTE 1: All voltage values are with respect to network ground terminal.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CO	ONDITIONS	MIN	TYP [†]	MAX	UNIT	
\/	High-level output voltage	T1OUT, T2OUT	$R_L = 3 \text{ k}\Omega \text{ to GND}$)	5	7		V	
VOH	r ligh-level output voltage	R1OUT, R2OUT	$I_{OH} = -1 \text{ mA}$		3.5			V	
V/a.	Lave lavel autout valta and	T1OUT, T2OUT	$R_L = 3 \text{ k}\Omega \text{ to GND}$)		-7	- 5	٧	
VOL	Low-level output voltage‡	R1OUT, R2OUT	$I_{OL} = 3.2 \text{ mA}$				0.4	V	
VIT+	Receiver positive-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	T _A = 25°C		1.7	2.4	٧	
VIT-	Receiver negative-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	T _A = 25°C	0.8	1.2		٧	
Vhys	Input hysteresis voltage	R1IN, R2IN	V _{CC} = 5 V		0.2	0.5	1	V	
ri	Receiver input resistance	R1IN, R2IN	V _{CC} = 5,	T _A = 25°C	3	5	7	kΩ	
ro	Output resistance	T1OUT, T2OUT	$V_{S+} = V_{S-} = 0,$	$V_O = \pm 2 V$	300			Ω	
IOS§	Short-circuit output current	T1OUT, T2OUT	$V_{CC} = 5.5 \text{ V},$	V _O = 0		±10		mA	
IIS	Short-circuit input current	T1IN, T2IN	V _I = 0				200	μΑ	
ICC	Supply current		V _{CC} = 5.5 V, T _A = 25°C	All outputs open,		8	10	mA	

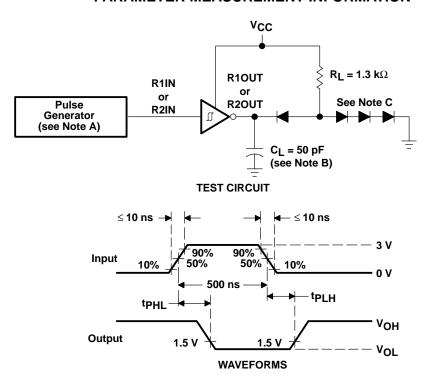
switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CONDITIONS	MIN TYP MA	UNIT
tPLH(R)	Receiver propagation delay time, low- to high-level output	See Figure 1	500	ns
tPHL(R)	Receiver propagation delay time, high- to low-level output	See Figure 1	500	ns
SR	Driver slew rate	R_L = 3 kΩ to 7 kΩ, See Figure 2	3	V/μs
SR(tr)	Driver transition region slew rate	See Figure 3	3	V/μs

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

[§] Not more than one output should be shorted at a time.

PARAMETER MEASUREMENT INFORMATION



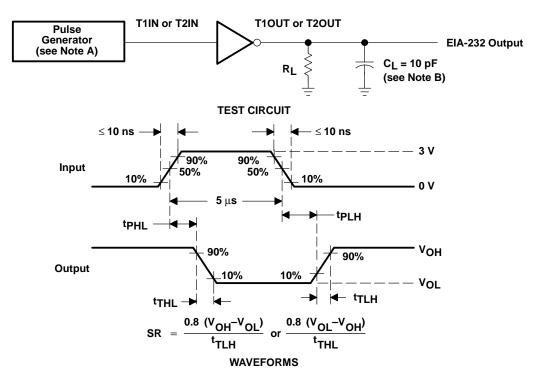
NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$.

- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.

Figure 1. Receiver Test Circuit and Waveforms for t_{PHL} and t_{PLH} Measurements



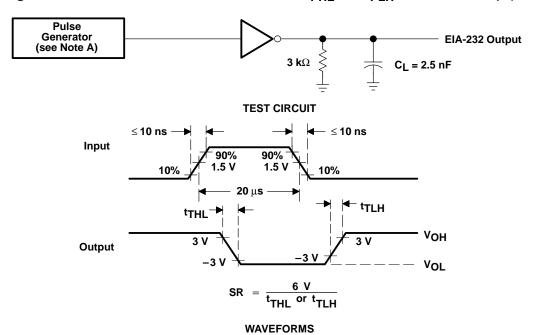
PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$.

B. C_L includes probe and jig capacitance.

Figure 2. Driver Test Circuit and Waveforms for tpHL and tpLH Measurements (5-µs input)



NOTE A: The pulse generator has the following characteristics: $Z_{\mbox{O}}$ = 50 Ω , duty cycle \leq 50%.

Figure 3. Test Circuit and Waveforms for t_{THL} and t_{TLH} Measurements (20- μ s input)



APPLICATION INFORMATION

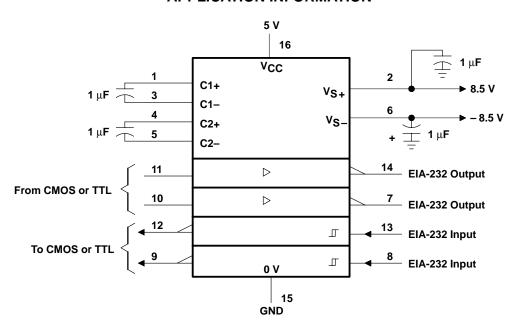


Figure 4. Typical Operating Circuit



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Mailing Address:

Texas Instruments
Post Office Box 655303
Dallas, Texas 75265